## Application/Control No. Applicant(s)/Patent Under Reexamination 10/808,647 CHANG ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 2822 Toniae M. Thomas **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0048840 A1 04-2002 Tanigawa, Kouichi Α 438/65 US-2004/0166606 A1 08-2004 Forehand, David 438/106 В

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